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EXPEDITED PROCEDURE
EXAMINING GROUP 2876

PATENT APPLICATION

Docket No.: 9903-041

Client Ref. No.: S01US012

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Sung-Muk LIM, et al.

Serial No.: 10/027,639 Examiner: Trail, Allyson N.

Filed: December 19, 2001 Group Art Unit: 2876

Confirmation No.: 1485

For: METHOD AND APPARATUS FOR DETECTING DEFECTIVE
MARKINGS ON A SEMICONDUCTOR PRODUCTMail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450**AMENDMENT AFTER FINAL REJECTION UNDER 37 CFR 1.116**

Responsive to the Final Office Action, Paper No. 05-2005, dated May 6, 2005, please amend the application as follows.

Amendments to the Claims are reflected in the listing of claims, which begins on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.